

Notice of References Cited

Application/Control No.

10/617,248

Applicant(s)/Patent Under
Reexamination
EICH ET AL.

Examiner

Yonel Beaulieu

Art Unit

3661

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,676,561 B2	01-2004	Fritzer et al.	477/70
	B	US-			
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	D	US-			
	E	US-			
	F	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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